Notice of References Cited

Application/Control No. Applicant(s)/Patent Under Reexam 09/893,988 Eom · Examiner Art Unit 2815 Page 1 of 2 Edgardo Ortiz

U.S. PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Name	Classification ²	
А	6,229,582	5/2001	Van Slooten	349	32
В	5,276,378	1/1994	Gothard	313	491
С	6,011,354	1/2000	Tsai Et.al.	313	634
D	6,016,032	1/2000	Buzak Et.al.	313	493
E	5,984,747	11/1999	Bhagavatula Et.al.	445	24
F	6,400,423	6/2002	French	349	32
G	6,169,364	1/2001	Van Slooten Et.al.	313	582
н	5,627,431	5/1997	Hayashi	313	584
ı	6,060,827	5/2000	Kichimi Et.al.	313	582
J	5,596,431	6/1997	Bongaerts Et.al.	349	32
К	6,373,185	4/2002	Tyler	313	491
L	5,343,116	8/1994	Winsor	313	493
м	5,850,122	12/1998	Winsor	313	493

FOREIGN PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY ¹	Country	Name	Classification ²	
N						
0						
 Р						
 a						
 R						
s						
Т						

NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
υ	
v	
w	
x	

^{*} A copy of this reference is not being furnished with this Office action. See MPEP \$ 707.05(a).

² Classifications may be U.S. or foreign.

Notice of References Cited

Application/Control No. 09/893,988	•	Applicant(s)/Paten	t Under Reexam om
Examiner Edgardo Ortiz		Art Unit 2815	Page 2 of 2

U.S. PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code MM-YYYY' Name		Classification		
A	6,114,809	9/2000	Winsor	315	50
В	5,313,223	5/1994	Buzak Et.al.	345	60
С					
D					
E		-			
F					
G					
н					
ł					
J			·		
К					
L					
М					

FOREIGN PATENT DOCUMENTS

	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification ²
N					
0					
Р					
۵					
R		·			
s					
т					

NON-PATENT DOCUMENTS

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
v	
w	
x	

^{*} A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

¹ Dates in MM-YYYY format are publication dates.

² Classifications may be U.S. or foreign.